The Latest X-ray Equipment and Method For Nanotechnology (SAXS)



Purpose of SAXS

<u>Small</u> <u>Angle</u> <u>X</u>-ray <u>S</u>cattering

Particle size estimation





• Phase identification

















SAXS geometry



$$A(\mathbf{q}) = \int_{V} \Delta \rho(\mathbf{r}) \exp(i\mathbf{q}\mathbf{r}) d\mathbf{r}$$

$$q = \frac{4\pi}{\lambda} \sin \frac{2\theta}{2}$$

Scattering amplitude from electron density fluctuations Is given as FT of the density fluctuations



Particle information

Particle size and particle distribution



Particle size and SAXS profile



Shape of SAXS: Breadth of distribution Slope of SAXS : Average particle size



Scattering measurement range

SAXS (1--140 nm) SAXS - super molecular structure X-ray (macromolecules, molecular aggregates) 🎽 WAXS (0.1 - 1 nm) WAXS - Inter molecular distances Porod region SAXS WAXS $(I(q) \propto q^{-4})$ 10⁵ Guinier Power-law region Intensity (arb. units) region <u>Guinier plot - $ln I(q) vs q^2$ </u> $I(q) \propto q^{-2}$ $q < 1.3/R_{a}$ 10 10 Debye form 10³ a = 3 Å10 10⁻² 10⁻¹ 10⁰ q (1/Å)

Scattering measurement range



Porod law (high `q` limit)

at large q,

 $I(q) \propto Q^{-n}$





Guinier`s law (low `q` limit)

$$I(q) = (\rho v)^2 \exp\left(-q^2 R_g^2/3\right)$$

$$\ln I(q) = \ln(\rho v)^2 - \left(\frac{R_g^2}{3}\right) q^2$$



$$I(q)_{q \to \infty} = 2\pi S(\rho_1 - \rho_2)^2 q^{-4}$$

S surface area per unit volume

Phase information

• The structure of long period



SAXS Optics



Rigaku

Line focusing optics

• D/Max 2200 & D/Max 2500

- You can obtain high resolution SAXS profiles





Line focusing optics

• SmartLab, Ultima IV & TTRAX III

– You can switch SAXS and Wide angle X-ray diffraction





Point focusing optics

NANO-Viewer (2D-SAXS System)

You can evaluate Nano-structures



NANO-Solver

• Automatic particle size & distribution estimation!





Relations of size and profiles

• Size: 3 nm

• Size: 60 nm



Relations of dispersion and profiles

Dispersion: 10 %
Dispersion: 90 %



The advantages of SAXS

- Easy sample preparation (non-destructive measurement)
- There is no limit of a sample state (solution, powder, bulk)
- A particle does not have to be a crystalline structure
- Quick measurement and quick analysis
- The average particle size and distribution information in the sample can be estimated
- The particle/pore size you can analyze is about 1~100 nm (in particular, sensitivity is high in less than 10 nm)



The disadvantages of SAXS

- Cannot distinguish between particles and pores
- Cannot distinguish particle information of an individual component, in case of many components
 - Cannot distinguish the scatter by SAXS profile
- A low density sample is difficult
 - Depends on an electronic density difference of a particle and a matrix
- Cannot measure the sample that X-rays cannot penetrate it (Transmission method)
 - When the solvent is with a big absorption coefficient
 - When sample thickness can not be changed



Applications of SAXS

Particle size estimation transmission mode & reflection mode



SAXS profiles and size distribution

• Au nanoparticles



Comparison of TEM image



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Nano size Cd-Se particles distribution

No.1 No.2 No.3 No.4 No.5





Correlation of fluorescence with SAXS



Nano size of porous silica

Mesoporous silica



Applications of SAXS

Phase identification



Block copolymer





Block copolymer



Block copolymer



Changeable horny layer

Human skin



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Summary Small angle X-ray scattering method





- Ultima IV, TTRAX III
 - Particle size and distribution
 - Phase identification
- Nano-viewer
 - Phase identification
 - Particle size and distribution

SAXS is for your Nano-technology development!

